

Important notice

Dear Customer,

On 7 February 2017 the former NXP Standard Product business became a new company with the tradename **Nexperia**. Nexperia is an industry leading supplier of Discrete, Logic and PowerMOS semiconductors with its focus on the automotive, industrial, computing, consumer and wearable application markets

In data sheets and application notes which still contain NXP or Philips Semiconductors references, use the references to Nexperia, as shown below.

Instead of http://www.nxp.com, http://www.nxp.com, http://www.nexperia.com/, http://www.nexperia.com/, use http://www.nexperia.com/

Instead of sales.addresses@www.nxp.com or sales.addresses@www.semiconductors.philips.com, use salesaddresses@nexperia.com (email)

Replace the copyright notice at the bottom of each page or elsewhere in the document, depending on the version, as shown below:

- © NXP N.V. (year). All rights reserved or © Koninklijke Philips Electronics N.V. (year). All rights reserved

Should be replaced with:

- © Nexperia B.V. (year). All rights reserved.

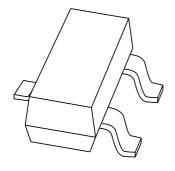
If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via **salesaddresses@nexperia.com**). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia

DISCRETE SEMICONDUCTORS

DATA SHEET



PBSS9110T 100 V, 1 A PNP low $V_{CEsat (BISS)}$ transistor

Product data sheet Supersedes data of 2004 May 06 2004 May 13



100 V, 1 A PNP low V_{CEsat (BISS)} transistor

PBSS9110T

FEATURES

- SOT23 package
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability: I_C and I_{CM}
- Higher efficiency leading to less heat generation

APPLICATIONS

- · Major application segments
 - Automotive 42 V power
 - Telecom infrastructure
 - Industrial
- DC-to-DC conversion
- · Peripheral drivers
 - Driver in low supply voltage applications (e.g. lamps and LEDs).
 - Inductive load driver (e.g. relays, buzzers and motors).

DESCRIPTION

PNP low V_{CEsat} transistor in a SOT23 plastic package. NPN complement: PBSS8110T.

MARKING

TYPE NUMBER	MARKING CODE(1)
PBSS9110T	*U7

Note

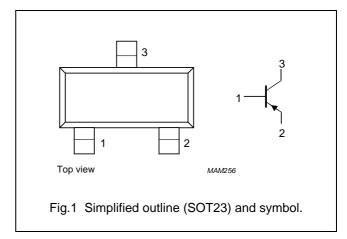
- 1. * = p: Made in Hong Kong.
 - * = t: Made in Malaysia.
 - * = W: Made in China.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	-100	V
I _C	collector current (DC)	-1	Α
I _{CM}	repetitive peak collector current	-3	Α
R _{CEsat}	equivalent on-resistance	320	mΩ

PINNING

PIN	DESCRIPTION
1	base
2	emitter
3	collector



ORDERING INFORMATION

TYPE NUMBER	PACKAGE			
TIPE NOWIDER	NAME DESCRIPTION VERSION			
PBSS9110T	_	plastic surface mounted package; 3 leads	SOT23	

100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

PBSS9110T

LIMITING VALUES

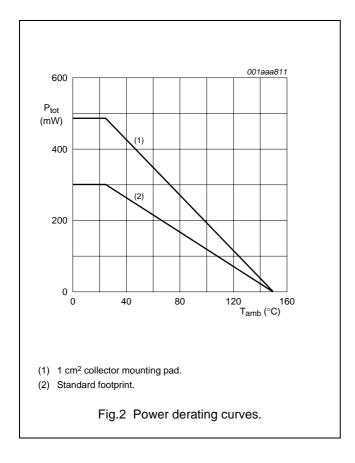
In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	_	-120	V
V_{CEO}	collector-emitter voltage	open base	-	-100	V
V _{EBO}	emitter-base voltage	open collector	_	-5	V
I _C	collector current (DC)		-	-1	Α
I _{CM}	peak collector current	limited by T _{j(max)}	-	-3	Α
I _B	base current (DC)		_	-300	mA
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C; note 1	-	300	mW
		T _{amb} ≤ 25 °C; note 2	-	480	mW
Tj	junction temperature		_	150	°C
T _{amb}	operating ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

Notes

- 1. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and 1 cm² collector mounting pad.

3



2004 May 13

100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

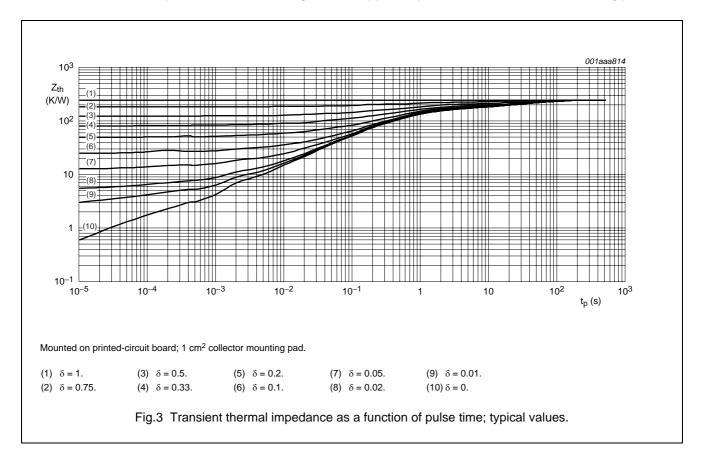
PBSS9110T

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th(j-a)}	thermal resistance from junction to	in free air; note 1	417	K/W
	ambient	in free air; note 2	260	K/W

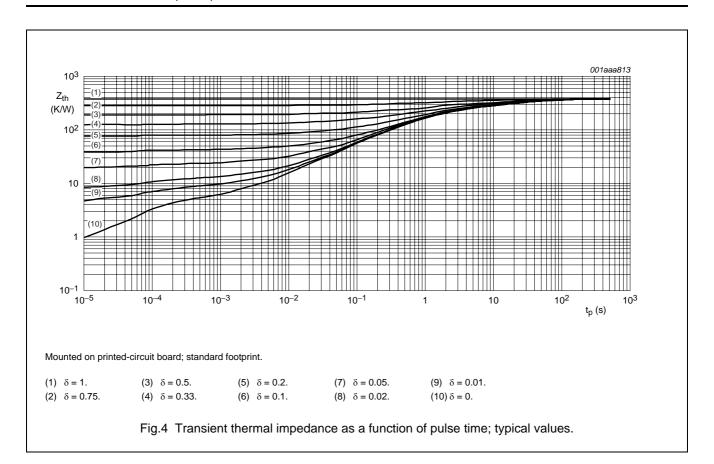
Notes

- 1. Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and 1 cm² collector mounting pad.



100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

PBSS9110T



100 V, 1 A PNP low $V_{\text{CEsat (BISS)}}$ transistor

PBSS9110T

CHARACTERISTICS

 T_j = 25 °C unless otherwise specified.

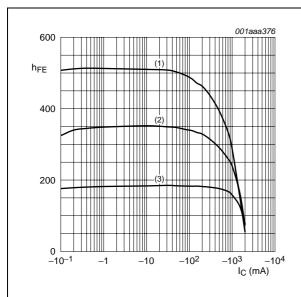
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector-base cut-off current	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}$	_	_	-100	nA
		$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}; T_j = 150 ^{\circ}\text{C}$	_	_	-50	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = -80 \text{ V}; V_{BE} = 0 \text{ A}$	_	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -4 \text{ V}; I_C = 0 \text{ A}$	_	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	150	-	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -250 \text{ mA}$	150	-	_	
		$V_{CE} = -5 \text{ V}; I_{C} = -500 \text{ mA}; \text{ note 1}$	150	-	450	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}; \text{ note 1}$	125	-	-	
V _{CEsat}	collector-emitter saturation voltage	$I_C = -250 \text{ mA}; I_B = -25 \text{ mA}$	_	-	-120	mV
		$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	_	_	-180	mV
		$I_C = -1 \text{ A}$; $I_B = -100 \text{ mA}$; note 1	_	-	-320	mV
R _{CEsat}	equivalent on-resistance	$I_C = -1 \text{ A}$; $I_B = -100 \text{ mA}$; note 1	_	170	320	mΩ
V_{BEsat}	base-emitter saturation voltage	$I_C = -1 \text{ A}; I_B = -100 \text{ mA}$	_	_	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	_	-	-1	V
f _T	transition frequency	$V_{CE} = -10 \text{ V; } I_{C} = -50 \text{ mA;}$ f = 100 MHz	100	_	_	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = I_e = 0 \text{ A};$ f = 1 MHz	_	_	17	pF

Note

1. Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$

100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

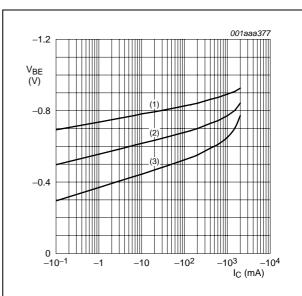
PBSS9110T



 $V_{CE} = -10 \text{ V}.$

- (1) T_{amb} = 100 °C.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

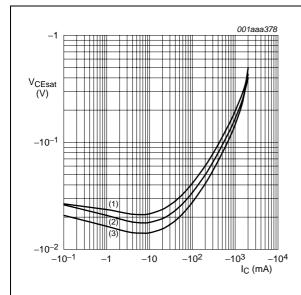
Fig.5 DC current gain as a function of collector current; typical values.



 $V_{CE} = -10 \text{ V}.$

- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = 100 \, ^{\circ}C$.

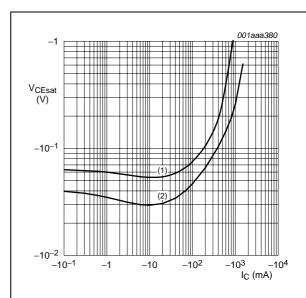
Fig.6 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 10.$

- (1) $T_{amb} = 100 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Fig.7 Collector-emitter saturation voltage as a function of collector current; typical values.



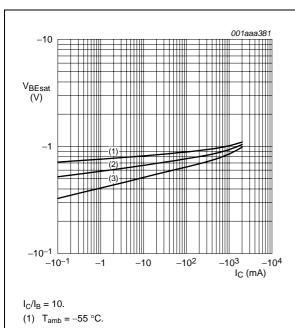
 $T_{amb} = 25 \, ^{\circ}C.$

- (1) $I_C/I_B = 50$.
- (2) $I_C/I_B = 20$.

Fig.8 Collector-emitter saturation voltage as a function of collector current; typical values.

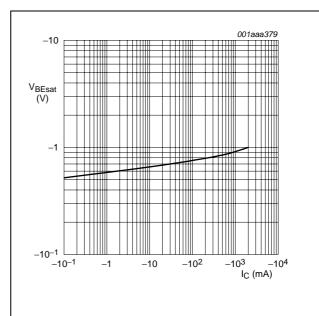
100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

PBSS9110T



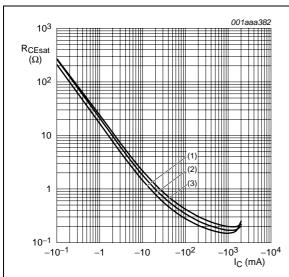
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = 100 \, ^{\circ}C$.

Fig.9 Base-emitter saturation voltage as a function of collector current; typical values.



 $I_C/I_B = 20$. $T_{amb} = 25 \,^{\circ}C$.

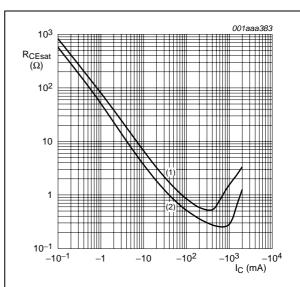
Fig.10 Base-emitter saturation voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 10.$

- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \,^{\circ}C$.
- (3) $T_{amb} = 100 \, ^{\circ}C$.

Fig.11 Equivalent on-resistance as a function of collector current; typical values.



 $T_{amb} = 25 \, ^{\circ}C.$

- (1) $I_C/I_B = 50$.
- (2) $I_C/I_B = 20$.

Fig.12 Equivalent on-resistance as a function of collector current; typical values.

100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

PBSS9110T

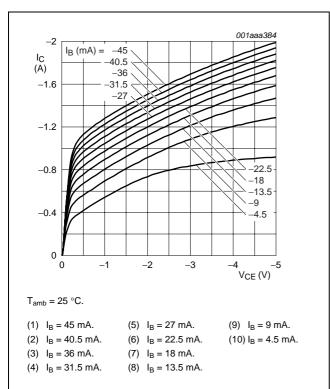
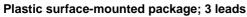


Fig.13 Collector current as a function of collector-emitter voltage; typical values.

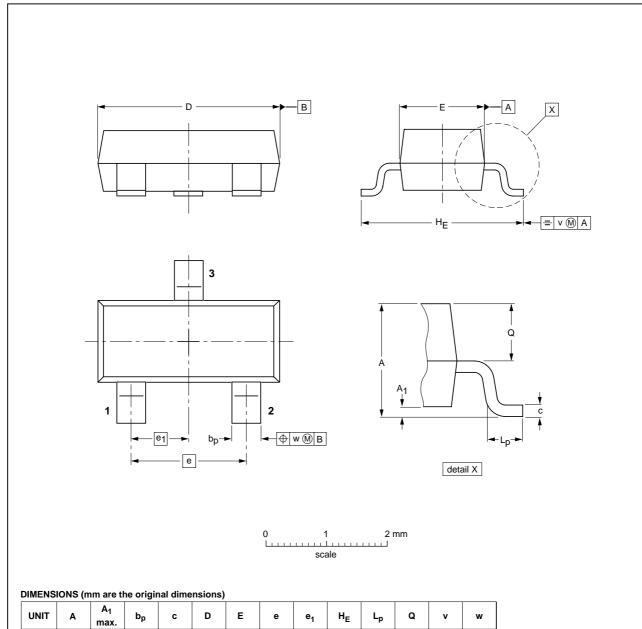
100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

PBSS9110T

PACKAGE OUTLINE



SOT23



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT23		TO-236AB				04-11-04 06-03-16

0.95

1.9

0.45

0.55

0.2

0.1

2004 May 13 10

0.48

0.38

0.15

1.1

0.9

100 V, 1 A PNP low V_{CEsat (BISS)} transistor

PBSS9110T

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

Notes

- 1. Please consult the most recently issued document before initiating or completing a design.
- The product status of device(s) described in this document may have changed since this document was published
 and may differ in case of multiple devices. The latest product status information is available on the Internet at
 URL http://www.nxp.com.

DISCLAIMERS

General — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions

above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by NXP Semiconductors. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.